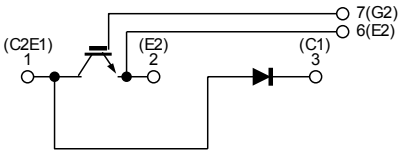
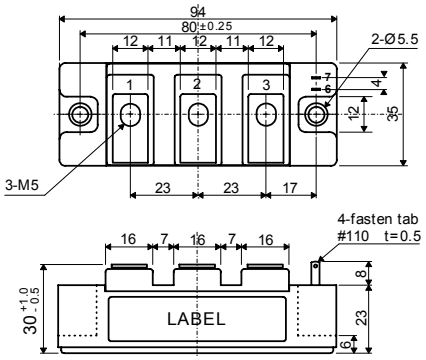
ＩＧＢＴ Module-Chopper　　５０Ａ, 600V　　ＰＲＨＭＢ５０Ｅ６

□ 回路図 : *CIRCUIT*



□ 外形寸法図 : *OUTLINE DRAWING*



Dimension: [mm]

□ 最大定格 : *MAXIMUM RATINGS* （T_C＝２５℃）

Ｉｔｅｍ		Ｓｙｍｂｏｌ	Ｒａｔｅｄ Ｖａｌｕｅ	Ｕｎｉｔ
コレクタ・エミッタ間電圧 Collector-Emitter Voltage		V_{CES}	６００	V
ゲート・エミッタ間電圧 Gate-Emitter Voltage		V_{GES}	±２０	V
コレクタ電流 Collector Current	ＤＣ	I_C	５０	A
	１ｍｓ	I_{CP}	１００	
コレクタ損失 Collector Power Dissipation		P_C	２５０	W
接合温度 Junction Temperature Range		T_j	－４０～＋１５０	℃
保存温度 Storage Temperature Range		T_{stg}	－４０～＋１２５	℃
絶縁耐圧(Terminal to Base AC, 1minute) Isolation Voltage		V_{ISO}	２，５００	$V_{(RMS)}$
締め付けトルク Mounting Torque	Module Base to Heatsink	F_{tor}	２	N・m (kgf・cm)
	Busbar to Main Terminal		２（２０.４）	

□ 電気的特性 : *ELECTRICAL CHARACTERISTICS* （T_C＝２５℃）

Ｃｈａｒａｃｔｅｒｉｓｔｉｃ		Ｓｙｍｂｏｌ	Ｔｅｓｔ Ｃｏｎｄｉｔｉｏｎ	Ｍｉｎ.	Ｔｙｐ.	Ｍａｘ.	Ｕｎｉｔ
コレクタ遮断電流 Collector-Emitter Cut-Off Current		I_{CES}	V_{CE}= 600V, V_{GE}= 0V	－	－	１.０	mA
ゲート漏れ電流 Gate-Emitter Leakage Current		I_{GES}	V_{GE}= ±20V, V_{CE}= 0V	－	－	１.０	μA
コレクタ・エミッタ間飽和電圧 Collector-Emitter Saturation Voltage		$V_{CE(sat)}$	I_C= 50A, V_{GE}= 15V	－	２.１	２.６	V
ゲートしきい値電圧 Gate-Emitter Threshold Voltage		$V_{GE(th)}$	V_{CE}= 5V, I_C= 50mA	４.０	－	８.０	V
入力容量 Input Capacitance		C_{ies}	V_{CE}= 10V, V_{GE}= 0V, f= 1MHz	－	２,５００	－	pF
スイッチング時間 Switching Time	上昇時間 Rise Time	t_r	V_{CC}= 300V R_L= 6.0Ω R_G= 20.0Ω V_{GE}= ±15V	－	０.１５	０.３０	μs
	ターンオン時間 Turn-on Time	t_{on}		－	０.２５	０.４０	
	下降時間 Fall Time	t_f		－	０.１０	０.３５	
	ターンオフ時間 Turn-off Time	t_{off}		－	０.３５	０.７０	

□フリーホイーリングダイオードの特性: *FREE WHEELING DIODE RATINGS & CHARACTERISTICS* （T_C＝２５℃）

Ｉｔｅｍ		Ｓｙｍｂｏｌ	Ｒａｔｅｄ Ｖａｌｕｅ	Ｕｎｉｔ
順電流 Forward Current	ＤＣ	I_F	５０	A
	１ｍｓ	I_{FM}	１００	

Ｃｈａｒａｃｔｅｒｉｓｔｉｃ	Ｓｙｍｂｏｌ	Ｔｅｓｔ Ｃｏｎｄｉｔｉｏｎ	Ｍｉｎ.	Ｔｙｐ.	Ｍａｘ.	Ｕｎｉｔ
順電圧 Peak Forward Voltage	V_F	I_F= 50A, V_{GE}= 0V	－	１.９	２.４	V
逆回復時間 Reverse Recovery Time	t_{rr}	I_F= 50A, V_{GE}= -10V di/dt= 100A/μs	－	０.１５	０.２５	μs

□ 熱的特性 : *THERMAL CHARACTERISTICS*

Ｃｈａｒａｃｔｅｒｉｓｔｉｃ		Ｓｙｍｂｏｌ	Ｔｅｓｔ Ｃｏｎｄｉｔｉｏｎ	Ｍｉｎ.	Ｔｙｐ.	Ｍａｘ.	Ｕｎｉｔ
熱抵抗 Thermal Impedance	ＩＧＢＴ	Rth(j-c)	Junction to Case (Tc測定点チップ直下)	－	－	０.５０	℃／W
	Diode			－	－	１.１０	

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Fig.1- Output Characteristics (Typical)

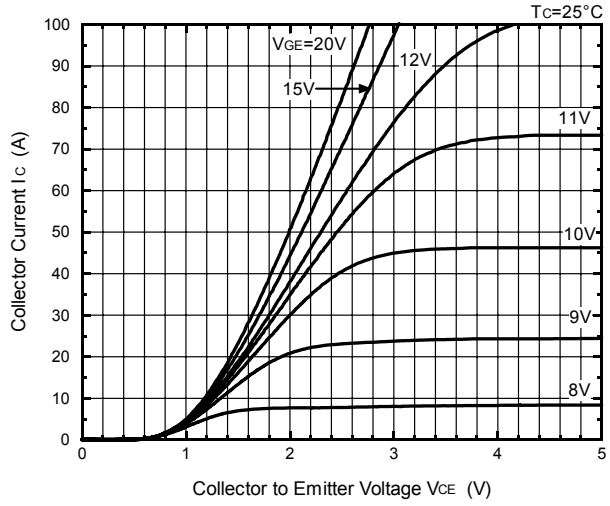

Fig.2- Output Characteristics (Typical)

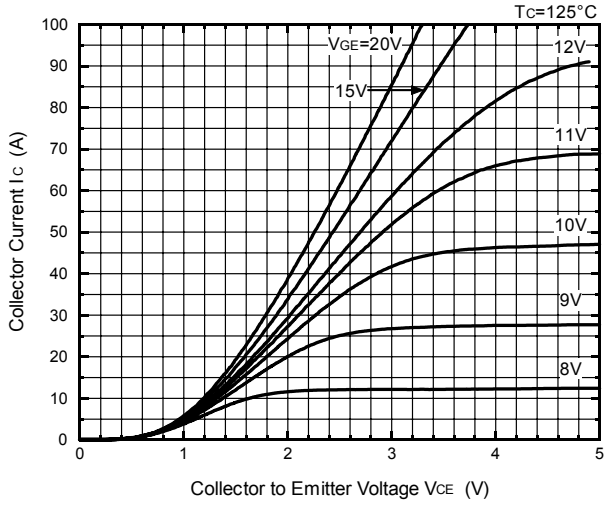

Fig.3- Collector to Emitter On Voltage vs. Gate to Emitter Voltage (Typical)

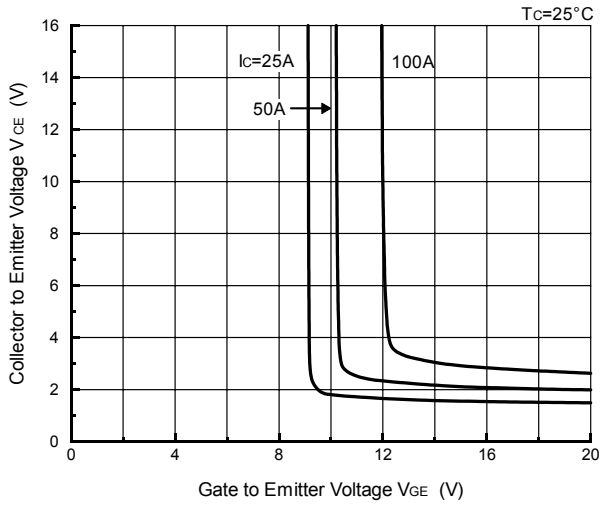

Fig.4- Collector to Emitter On Voltage vs. Gate to Emitter Voltage (Typical)

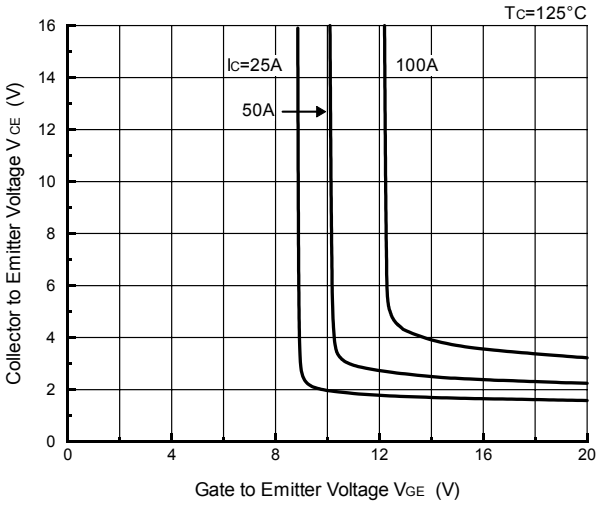

Fig.5- Gate Charge vs. Collector to Emitter Voltage (Typical)

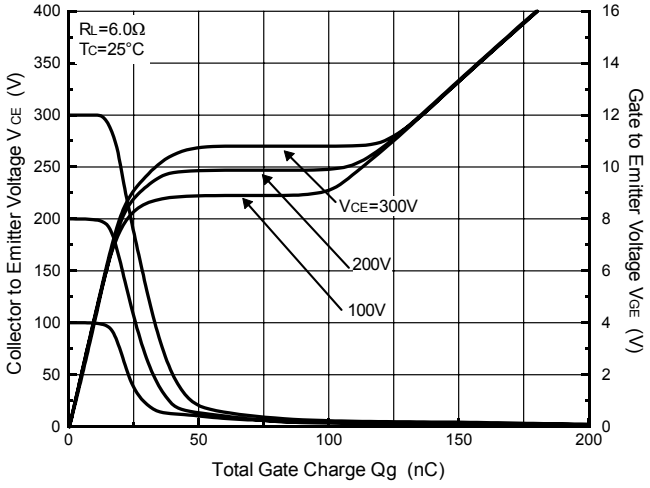

Fig.6- Capacitance vs. Collector to Emitter Voltage (Typical)

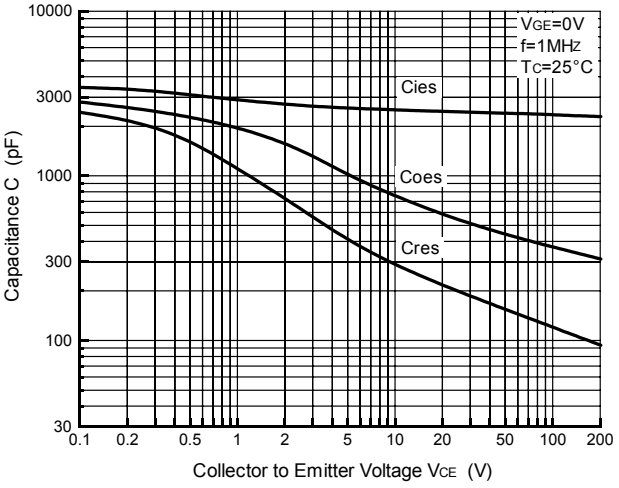

Fig.7- Collector Current vs. Switching Time (Typical)

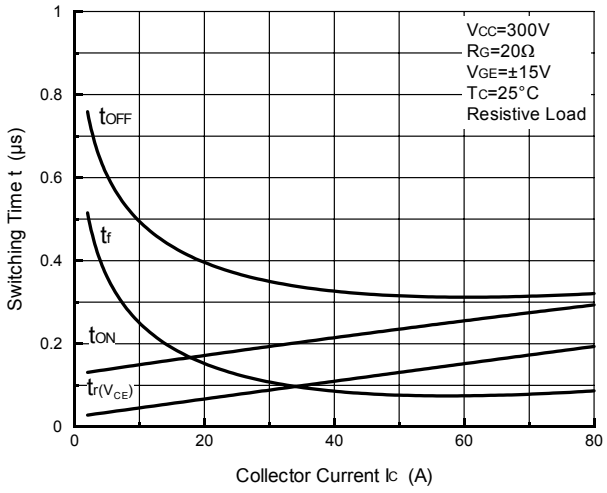

Fig.8- Series Gate Impedance vs. Switching Time (Typical)

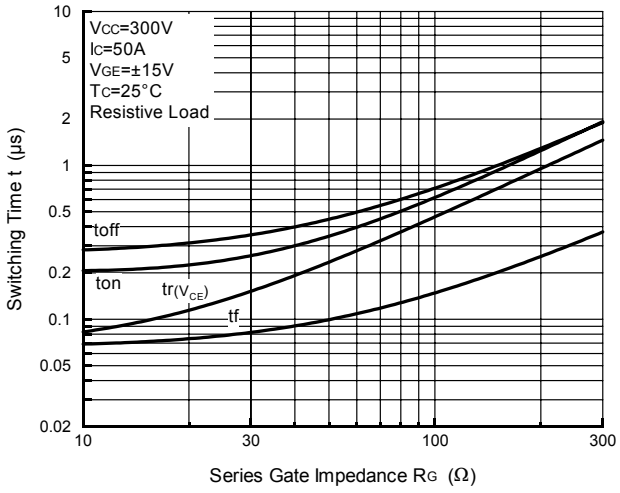

Fig.9- Collector Current vs. Switching Time

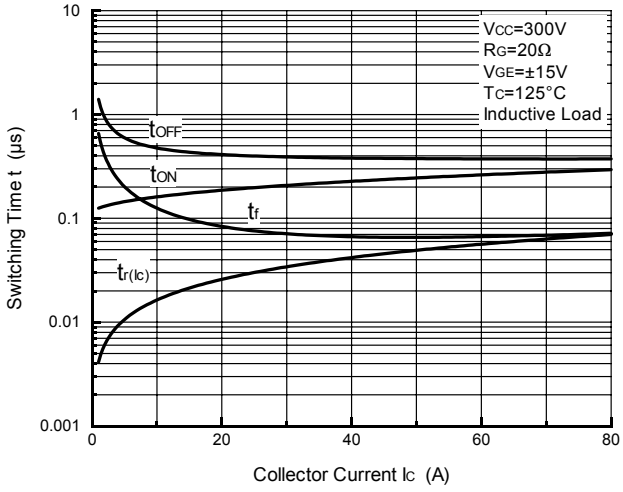

Fig.10- Series Gate Impedance vs. Switching Time

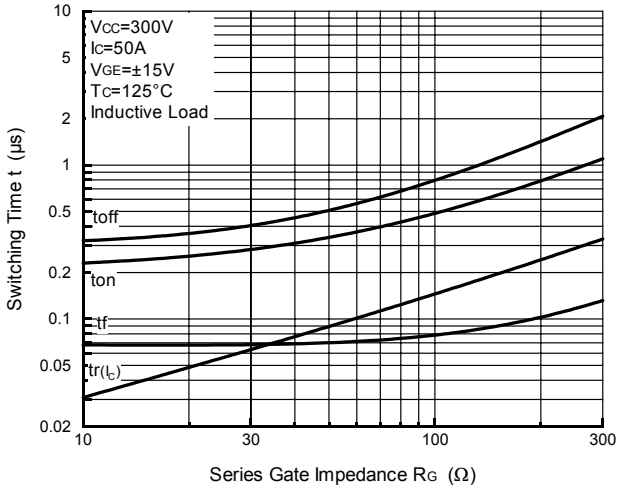

Fig.11- Collector Current vs. Switching Loss

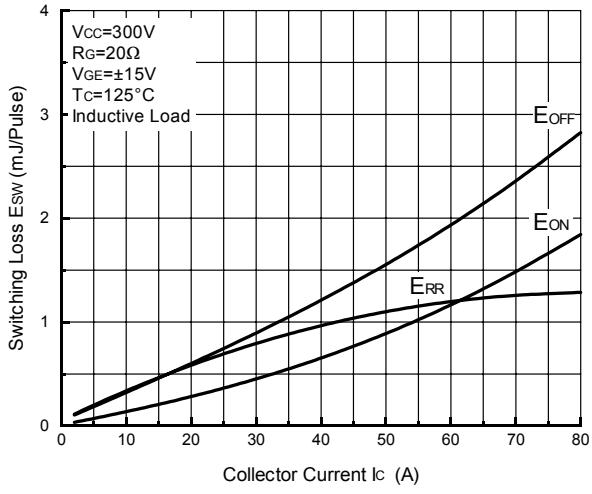

Fig.12- Series Gate Impedance vs. Switching Loss

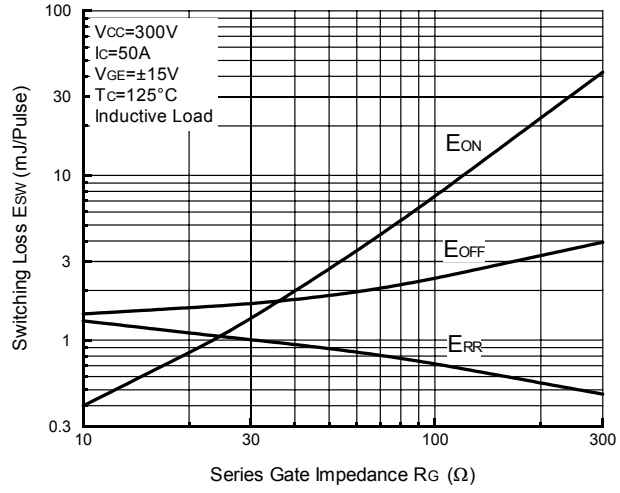

Fig.13- Forward Characteristics of Free Wheeling Diode (Typical)

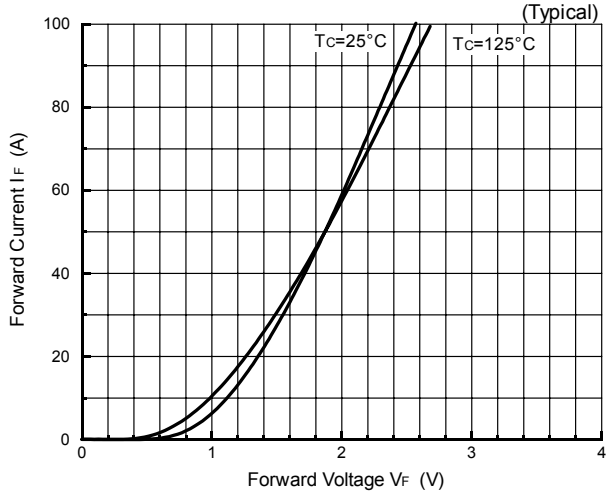

Fig.14- Reverse Recovery Characteristics (Typical)

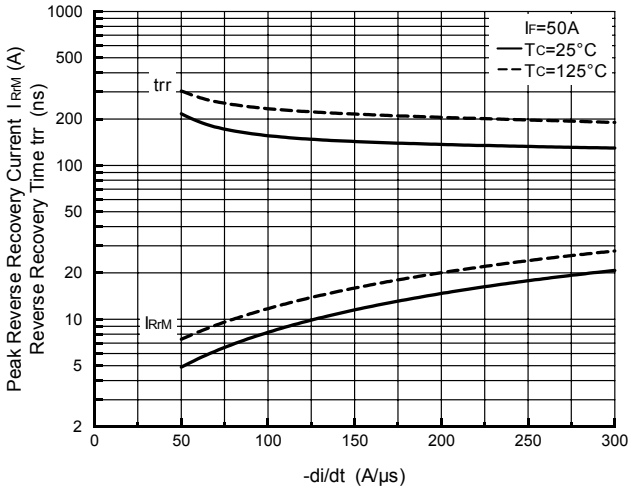

Fig.15- Reverse Bias Safe Operating Area

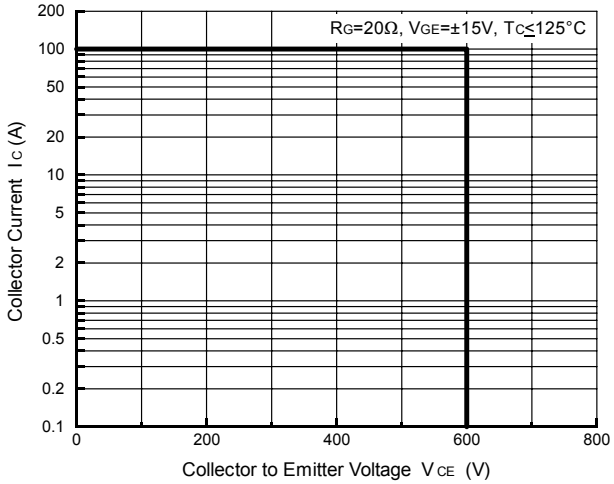

Fig.16- Transient Thermal Impedance